		La	<u> </u>	I m:
L Number	Hits	Search Text	DB	Time stamp
=	31857	<pre>(stability or fixedness) same (equipmen\$ or apparat\$)</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT;	2002/03/28 11:32
-	87	<pre>(dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$))</pre>	IBM TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2002/03/22 22:20
-	0	<pre>((dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and (inspect\$ same (sampl\$ with rate))</pre>	IBM TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21 15:24
-	0	<pre>((dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and (inspect\$ same (sampl\$ same rate))</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21 15:26
-	3	<pre>((dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and inspect\$ (((dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and inspect\$) and rate</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21 - 15:27
-	3	<pre>(((dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and database) and rate</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21 15:31
-	2	<pre>((((((dynamic\$ with monitor\$) and . ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and database) and rate) and input) and server</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21
	3	<pre>((((dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and database) and rate) and input</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21
-	6	<pre>((dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and database</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21 15:35
_	3	<pre>((dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$) and inspect\$</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21 15:35
-	50	<pre>(dynamic\$ with monitor\$) and ((stability or fixedness) same (equipmen\$ or apparat\$)) and product\$</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/21 15:38
-	666425	(manufactur\$ or equipment) and (monitor\$ or measur\$)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/22 22:28
-	171228	<pre>((manufactur\$ or equipment) and (monitor\$ or measur\$)) and (stability or reliability)</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/22 23:34

-	894		USPAT;	2002/03/22
		(monitor\$ or measur\$)) and (stability or	US-PGPUB;	23:37
		reliability)) and (semi with manufactur\$)	EPO; JPO; DERWENT;	
			IBM TDB	
_	59	((((manufactur\$ or equipment) and	USPAT;	2002/03/22
		(monitor\$ or measur\$)) and (stability or	US-PGPUB;	22:39
		reliability)) and (semi with	EPO; JPO;	
		manufactur\$)) and (sampl\$ with rat\$)	DERWENT;	
			IBM TDB	
-	0	(((((manufactur\$ or equipment) and	USPAT;	2002/03/22
		(monitor\$ or measur\$)) and (stability or	US-PGPUB;	22:36
		reliability)) and (semi with manufactur\$)) and (sampl\$ with rat\$)) and	EPO; JPO;	·
	·	(inspect\$ with product\$)	DERWENT; IBM TDB	
_	1165		USPAT;	2002/03/23
	1100	(monitor\$ or measur\$)) and (stability or	US-PGPUB;	00:18
		reliability)) and (inspect\$ with	EPO; JPO;	
		product\$)	DERWENT;	
			IBM TDB	
-	119	, , , , , , , , , , , , , , , , , , , ,	USPAT;	2002/03/22
1		(monitor\$ or measur\$)) and (stability or	US-PGPUB;	22:40
		reliability)) and (inspect\$ with	EPO; JPO;	
		product\$)) and (sampl\$ with rat\$)	DERWENT;	
_	63	(((((manufactur\$ or equipment) and	IBM TDB	2002/03/22
	03	(monitor\$ or measur\$)) and (stability or	US-PGPUB;	2002/03/22
		reliability)) and (inspect\$ with	EPO; JPO;	
		product\$)) and (sampl\$ with rat\$)) and	DERWENT;	
		(semi\$)	IBM TDB	
-	54		USPAT;	2002/03/22
		(monitor\$ or measur\$)) and (stability or	US-PGPUB;	23:38
		reliability)) and (inspect\$ with	EPO; JPO;	
		<pre>product\$)) and (sampl\$ with rat\$)) and (semi\$)) and (stor\$)</pre>	DERWENT; IBM TDB	
_	54		USPAT;	2002/03/22
	"	(monitor\$ or measur\$)) and (stability or	US-PGPUB;	22:52
		reliability)) and (inspect\$ with	EPO; JPO;	
		product\$)) and (sampl\$ with rat\$)) and	DERWENT;	
}		(semi\$)) and (stor\$)) and (process\$ or	IBM TDB	~
		control\$)		
-	45	(((((((manufactur\$ or equipment) and	USPAT;	2002/03/22
		<pre>(monitor\$ or measur\$)) and (stability or reliability)) and (inspect\$ with</pre>	US-PGPUB; EPO; JPO;	22:52
		product\$)) and (sampl\$ with rat\$)) and	DERWENT;	[
		(semi\$)) and (stor\$)) and (process\$ or	IBM TDB	
		control\$)) and (dynamic\$)		
-	44	((((((((manufactur\$ or equipment) and	USPAT;	2002/03/22
		(monitor\$ or measur\$)) and (stability or	US-PGPUB;	23:05
		reliability)) and (inspect\$ with	EPO; JPO;	
		product\$)) and (sampl\$ with rat\$)) and	DERWENT;	
		<pre>(semi\$)) and (stor\$)) and (process\$ or control\$)) and (dynamic\$)) and (monitor\$)</pre>	IBM TDB	
_	44	(((((((((manufactur\$ or equipment) and	USPAT;	2002/03/22
	7.3	(monitor\$ or measur\$)) and (stability or	US-PGPUB;	23:07
1		reliability)) and (inspect\$ with	EPO; JPO;	
		<pre>product\$)) and (sampl\$ with rat\$)) and</pre>	DERWENT;	
1		(semi\$)) and (stor\$)) and (process\$ or	IBM TDB	
		control\$)) and (dynamic\$)) and		
		(monitor\$)) and (determin\$ or analyz\$)	IICD»m.	2002/02/22
-	37	<pre>((((((((((((((((((((((((((((((((((((</pre>	USPAT; US-PGPUB;	2002/03/22
		reliability)) and (inspect\$ with	EPO; JPO;	23.12
]	product()) and (sampl() with rat()) and	DERWENT;	
		(semi\$)) and (stor\$)) and (process\$ or	IBM TDB	
		control\$)) and (dynamic\$)) and		
		(monitor\$)) and (determin\$ or analyz\$))		
	1	and (sampling same rate)		L
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(monitors or measurs)) and (stability or reliability) and (samplis with rats)) and (semis)) and (stability) and (semis)) and (stability) and (semis)) and (semis)) and (semis) and (semis)) and (semis) and (sem					0000/00/00
controls) and (dynamics) and (monitors) and (sampling adj rate) ((manufacturs or equipment) and (monitors) or measurs)) and (stability)	_	37	reliability)) and (inspect\$ with product\$)) and (sampl\$ with rat\$)) and	EPO; JPO; DERWENT;	2002/03/22 23:35
			<pre>control\$)) and (dynamic\$)) and (monitor\$)) and (determin\$ or analyz\$)) and (sampling adj rate)</pre>	IBM TDB	
(monitors) or measurs)) and (stability) US-PCPUB; 23:35 EPO; JPO; DERWENT; IBM TDB USPAT; USPACPUB; US	-	124156		US-PGPUB; EPO; JPO; DERWENT;	1
(monitors or measurs)) and (stability)	-	1061	(monitor\$ or measur\$)) and (stability))	US-PGPUB; EPO; JPO; DERWENT;	
34 ((((manufacturs or equipment) and (monitors) or measurs)) and (stability)) US-PCPUB; EPO; JPO; DRWENT; EMO JPO; DRWE		1632	(monitor\$ or measur\$)) and (stability))	USPAT; US-PGPUB; EPO; JPO; DERWENT;	1
Commitors or measurs) and (stability) and (sampling with rate) and (semis same manufacturs) Commitors or measurs) and (stability) Commitors or measurs C		34	<pre>(monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (inspect\$</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT;	
(monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (semi\$ same manufactur\$)) and (stor\$) (((((((manufactur\$ or equipment) and (monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (stability)) and (sampling with rate)) and (stability) and (sampling with rate)) and (first with second) - 16993 ((((manufactur\$ or equipment) and (monitor\$ or measur\$)) and (stability or reliability)) and (inspect\$) - 32 (((((((manufactur\$ or equipment) and (monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (stability)) and (sampling with rate)) and (sfirst with second) - 27 monitor\$ with stability with manufactu\$ - 27 monitor\$ with stability with manufactu\$ - 32 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 35 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 36 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 36 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 36 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 37 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 38 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 39 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 30 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 30 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 30 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 30 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 30 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 30 (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - 30 (monitor\$ with stability with manufactu\$) and (sampling with rate) a	_	176	<pre>(monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (semi\$ same</pre>	US-PGPUB; EPO; JPO; DERWENT;	
100	_	107	<pre>(monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (semi\$ same</pre>	US-PGPUB; EPO; JPO; DERWENT;	· · ·
16993	_	100	<pre>(monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (semi\$ same manufactur\$)) and (stor\$)) and (first</pre>	US-PGPUB; EPO; JPO; DERWENT;	
- 32 ((((((((manufactur\$ or equipment) and (monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (semi\$ same manufactur\$)) and (stor\$)) and (first with second)) and (inspect\$) - 27 monitor\$ with stability with manufactu\$ - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manufactu\$) and (sampl\$ and rate and stor\$) - (monitor\$ with stability with manu	-	16993	(((manufactur\$ or equipment) and (monitor\$ or measur\$)) and (stability or	USPAT; US-PGPUB; EPO; JPO; DERWENT;	1 ' '
- 27 monitor\$ with stability with manufactu\$ USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT;	-	32	<pre>(monitor\$ or measur\$)) and (stability)) and (sampling with rate)) and (semi\$ same manufactur\$)) and (stor\$)) and (first</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT;	1
- 13646 (monitor\$ with stability with manufactu\$) USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT;	_	. 27	with second); and (inspects) monitor\$ with stability with manufactu\$	USPAT; US-PGPUB; EPO; JPO; DERWENT;	
- 13646 stability with manufactu\$ USPAT; 2002/03/23 US-PGPUB; EPO; JPO; DERWENT;	_	6		USPAT; US-PGPUB; EPO; JPO; DERWENT;	
	- *	13646	stability with manufactu\$	USPAT; US-PGPUB; EPO; JPO;	

_	7746	<pre>(stability with manufactu\$) and (monitor\$) or measur\$ or determin\$ or analy\$ or sens\$)</pre>	USPAT; US-PGPUB; EPO; JPO;	2002/03/23 00:18
			DERWENT; IBM TDB	
_	205	((stability with manufactu\$) and (monitor\$ or measur\$ or determin\$ or analy\$ or sens\$)) and (sample with rate)	USPAT; US-PGPUB; EPO; JPO;	2002/03/23 00:18
	21	///atability with manufactue\ and	DERWENT; IBM TDB	2002/03/23
	21	<pre>(((stability with manufactus) and (monitors or measurs or determins or analys or senss)) and (sample with rate))</pre>	USPAT; US-PGPUB; EPO; JPO;	00:19
		and (inspect\$)	DERWENT; IBM TDB	
_	1	stability adj manufactur\$ adj equipment\$	USPAT; US-PGPUB; EPO; JPO; DERWENT;	2002/03/27
_	8762	manufactur\$ adj equipment\$	IBM TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/27 10:24
_	. 53	(manufactur\$ adj equipment\$) and (semi same manufactur\$ same product\$)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/27 10:25
-	17	(manufactur\$ adj equipment\$) and (sampling adj rate)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/27 10:29
_	1	<pre>(((manufactur\$ adj equipment\$) and (sampling adj rate)) and (first with second)) and inspect\$</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/27 10:31
~	14	(((manufactur\$ adj equipment\$) and (sampling adj rate)) and (first with second))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/27 10:33
-	240	(first adj sampling adj rate) and (second adj sampling adj rate)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/27 10:34
-	3	<pre>((first adj sampling adj rate) and (second adj sampling adj rate)) and (manufactur\$ with product\$)</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/27
-	5	<pre>((first adj sampling adj rate) and (second adj sampling adj rate)) and (inspect\$)</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/03/27
-	18282	sampling adj rate	USPAT; US-PGPUB; EPO; JPO; DERWENT;	2002/03/27 10:38
1			IBM TDB	

				1 = 200 / 200 / 200
-	284	(sampling adj rate	USPAT; US-PGPUB;	2002/03/27 10:39
) and (manufactur\$ with product\$)	EPO; JPO; DERWENT;	
-	103	((sampling adj rate	IBM TDB USPAT;	2002/03/27
) and (manufactur\$ with product\$)	US-PGPUB; EPO; JPO;	10:39
	:) and (semi\$)	DERWENT; IBM TDB	
-	90	(((sampling adj rate	USPAT; US-PGPUB;	2002/03/27
) and (manufactur\$ with product\$)	EPO; JPO; DERWENT;	
) and (semi\$)) and (inspect\$ or test\$)	IBM TDB	
-	90	((((sampling adj rate	USPAT; US-PGPUB;	2002/03/27
) and (manufactur\$ with product\$)	EPO; JPO; DERWENT;	
) and (semi\$)) and (inspect\$ or test\$)	IBM TDB	
) and (analyz\$ or calculat\$ or determin\$ or measur\$ or estimat\$)		
-	65	(((((sampling adj rate	USPAT; US-PGPUB;	2002/03/27
) and (manufactur\$ with product\$)	EPO; JPO; DERWENT;	
) and (semi\$)) and (inspect\$ or test\$)	IBM TDB	
) and (analyz\$ or calculat\$ or determin\$ or measur\$ or estimat\$)		
_	43) and (stor\$ and display\$) (((((sampling adj rate	USPAT; US-PGPUB;	2002/03/27
) and (manufactur\$ with product\$)	EPO; JPO; DERWENT;	10.77
		<pre>) and (semi\$)) and (inspect\$ or test\$)) and (analyz\$ or calculat\$ or determin\$ or measur\$ or estimat\$)) and (stor\$ and display\$)) and</pre>	IBM TDB	
_	27	(stability or reliability) (SPC adj analy\$) or (SPC same database	USPAT;	2002/03/27
		same analy\$)	US-PGPUB; EPO; JPO; DERWENT;	10:58
-	4	manufactur\$ adj executive adj system	IBM TDB USPAT; US-PGPUB;	2002/03/27 11:10
_	3	5505090.pn.	EPO; JPO; DERWENT; IBM TDB USPAT;	2002/03/28
			US-PGPUB; EPO; JPO; DERWENT; IBM TDB	11:37
-	2	6260941.pn.	USPAT; US-PGPUB;	2002/03/28
			EPO; JPO; DERWENT;	
	1	6353169.pn.	IBM TDB USPAT; US-PGPUB;	2002/03/28
			EPO; JPO; DERWENT;	11.37
		<u> </u>	IBM TDB	

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_	2	6276997.pn.	USPAT;	2002/03/28
	_		US-PGPUB;	11:39
			EPO; JPO;	
			DERWENT;	1
			IBM TDB	
_	1	6345259.pn.	USPAT;	2002/03/28
		-	US-PGPUB;	11:40
			EPO; JPO;	
			DERWENT;	.
			IBM TDB	
_	2	6190313.pn.	USPAT;	2002/03/28
		•	US-PGPUB;	11:40
			EPO; JPO;	
			DERWENT;	
			IBM TDB	